

Notice of References CitedApplication/Control No.
09/544,054Applicant(s)/Patent Under
Reexamination
YONA ET AL.Examiner
Christopher E. LeeArt Unit
2181

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,734,656	03-1998	Prince et al.	370/362
	B	US-5,838,681	11-1998	Bonomi et al.	710/116
	C	US-6,016,528	01-2000	Jaramillo et al.	710/107
	D	US-2001/0043700 A1	03-1999	SHIMA et al.	379/399.01
	E	US-6,400,819 B1	06-2002	Nakano et al.	379/229
	F	US-5,771,358	06-1998	LaBerge, Paul A.	710/107
	G	US-6,219,706 B1	04-2001	Fan et al.	709/225
	H	US-5,768,270	06-1998	Ha-Duong, Tuan	370/388
	I	US-5,875,351	02-1999	Riley, Dwight D.	710/22
	J	US-5,467,348	11-1995	Fujii et al.	370/399
	K	US-6,047,288	04-2000	Kurosawa et al.	707/10
	L	US-5,452,330	09-1995	Goldstein, Fred R.	370/395.1
	M	US-5,901,332	05-1999	Gephardt et al.	710/116

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.